


<b>Search Notes</b>  	<b>Application/Control No.</b>  10573492	<b>Applicant(s)/Patent Under Reexamination</b>  NANIWAE, KOICHI
	<b>Examiner</b>  ERIC W JONES	<b>Art Unit</b>  2892

SEARCHED			
Class	Subclass	Date	Examiner
438	689	8/21/2008	EJ

SEARCH NOTES		
Search Notes	Date	Examiner
Author search	3/17/2008	EJ
Key word search	8/21/2008	EJ
Key word search	3/24/2009	EJ
Key word search	3/25/2009	EJ
Key word search	3/26/2009	EJ
Discussed case with Thao Le	3/25/2009	EJ
IDS reference search	8/18/2009	EJ
Key word search	8/19/2009	EJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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